



IEEE Standard Requirements for Instrument Transformers

IEEE Power Engineering Society

Sponsored by the
Transformers Committee

IEEE
3 Park Avenue
New York, NY 10016-5997, USA
28 July 2008

IEEE Std C57.13™-2008
(Revision of
IEEE Std C57.13-1993)

Currently in preview, click buy full version

IEEE Std C57.13™-2008
(Revision of
IEEE Std C57.13-1993)

IEEE Standard Requirements for Instrument Transformers

Sponsor

Transformers Committee
of the
IEEE Power Engineering Society

Approved 27 March 2008
IEEE-SA Standards Board

Abstract: Electrical, dimensional, and mechanical characteristics are covered, taking into consideration certain safety features, for current and inductively coupled voltage transformers of types generally used in the measurement of electricity and the control of equipment associated with the generation, transmission, and distribution of alternating current. The aim is to provide a basis for performance and interchangeability of equipment covered and to assist in the proper selection of such equipment. Safety precautions are also addressed. Accuracy classes for metering service are provided. The test code covers measurement and calculation of ratio and phase angle, demagnetization, impedance and excitation measurements, polarity determination, resistance measurements, short-time characteristics, temperature rise tests, dielectric tests, and measurement of open-circuit voltage of current transformers.

Keywords: accuracy, current transformer, instrument transformer, primary winding, ratio, secondary voltage, routine tests, secondary winding, type tests, voltage transformer

The Institute of Electrical and Electronics Engineers, Inc.
3 Park Avenue, New York, NY 10016-5997, USA

Copyright © 2008 by the Institute of Electrical and Electronics Engineers, Inc.
All rights reserved. Published 28 July 2008. Printed in the United States of America.

IEEE is a registered trademark in the U.S. Patent & Trademark Office, owned by the Institute of Electrical and Electronics Engineers, Incorporated.

PDF: ISBN 978-0-7381-5410-7 STD95778
Print: ISBN 978-0-7381-5411-4 STDPD95778

No part of this publication may be reproduced in any form, in an electronic retrieval system or otherwise, without the prior written permission of the publisher.

IEEE Standards documents are developed within the IEEE Societies and the Standards Coordinating Committees of the IEEE Standards Association (IEEE-SA) Standards Board. The IEEE develops its standards through a consensus development process, approved by the American National Standards Institute, which brings together volunteers representing varied viewpoints and interests to achieve the final product. Volunteers are not necessarily members of the Institute and serve without compensation. While the IEEE administers the process and establishes rules to promote fairness in the consensus development process, the IEEE does not independently evaluate, test, or verify the accuracy of any of the information or the soundness of any judgments contained in its standards.

Use of an IEEE Standard is wholly voluntary. The IEEE disclaims liability for any personal injury, property or other damage, of any nature whatsoever, whether special, indirect, consequential, or compensatory, directly or indirectly resulting from the publication, use of, or reliance upon this, or any other IEEE Standard document.

The IEEE does not warrant or represent the accuracy or content of the material contained herein, and expressly disclaims any express or implied warranty, including any implied warranty of merchantability or fitness for a specific purpose, or that the use of the material contained herein is free from patent infringement. IEEE Standards documents are supplied **“AS IS.”**

The existence of an IEEE Standard does not imply that there are no other ways to produce, test, measure, purchase, market, or provide other goods and services related to the scope of the IEEE Standard. Furthermore, the viewpoint expressed at the time a standard is approved and issued is subject to change brought about through developments in the state of the art and comments received from users of the standard. Every IEEE Standard is subjected to review at least every five years for revision or reaffirmation. When a document is more than five years old and has not been reaffirmed, it is reasonable to conclude that its contents, although still of some value, do not wholly reflect the present state of the art. Users are cautioned to check to determine that they have the latest edition of any IEEE Standard.

In publishing and making this document available, the IEEE is not suggesting or rendering professional or other services for, or on behalf of, any person or entity. Nor is the IEEE undertaking to perform any duty owed by any other person or entity to another. Any person utilizing this, and any other IEEE Standards document, should rely upon his or her independent judgment in the exercise of reasonable care in any given circumstances or, as appropriate, seek the advice of a competent professional in determining the appropriateness of a given IEEE standard.

Interpretations: Occasionally questions may arise regarding the meaning of portions of standards as they relate to specific applications. When the need for interpretations is brought to the attention of IEEE, the Institute will initiate action to prepare appropriate responses. Since IEEE Standards represent a consensus of concerned interests, it is important to ensure that any interpretation has also received the concurrence of a balance of interests. For this reason, IEEE and the members of its societies and Standards Coordinating Committees are not able to provide an instant response to interpretation requests except in those cases where the matter has previously received formal consideration. A statement, written or oral, that is not processed in accordance with the IEEE-SA Standards Board Operations Manual shall not be considered the official position of IEEE or any of its committees and shall not be considered to be, nor be relied upon as, a formal interpretation of the IEEE. At lectures, symposia, seminars, or educational courses, an individual presenting information on IEEE standards shall make it clear that his or her views should be considered the personal views of that individual rather than the formal position, explanation, or interpretation of the IEEE.

Comments for revision of IEEE Standards are welcome from any interested party, regardless of membership affiliation with IEEE. Suggestions for changes in documents should be in the form of a proposed change of text, together with appropriate supporting comments. Comments on standards and requests for interpretations should be submitted to the following address:

Secretary, IEEE-SA Standards Board
445 Hoes Lane
Piscataway, NJ 08854
USA

Authorization to photocopy portions of any individual standard for internal or personal use is granted by The Institute of Electrical and Electronics Engineers, Inc., provided that the appropriate fee is paid to Copyright Clearance Center. To arrange for payment of licensing fee, please contact Copyright Clearance Center, Customer Service, 222 Rosewood Drive, Danvers, MA 01923 USA; +1 978 750 8400. Permission to photocopy portions of any individual standard for educational classroom use can also be obtained through the Copyright Clearance Center.

Introduction

This introduction is not part of IEEE Std C57.13-2008, IEEE Standard Requirements for Instrument Transformers.

This standard was prepared by the Instrument Transformer Subcommittee of the Transformers Committee of the IEEE Power Engineering Society. The purpose of this standard is to cover the electrical, dimensional, and mechanical characteristics and to take into consideration certain safety features, for current and inductively coupled voltage transformers.

The changes in this revision of this standard are to the rated voltage rating of voltage transformers to eliminate the confusion caused by the specification of the primary voltage and the system voltage for line-to-ground transformers. An addition of partial discharge testing was added to the test section.

Notice to users

Laws and regulations

Users of these documents should consult all applicable laws and regulations. Compliance with the provisions of this standard does not imply compliance to any applicable regulatory requirements. Implementers of the standard are responsible for observing or referring to the applicable regulatory requirements. IEEE does not, by the publication of its standards, intend to urge action that is not in compliance with applicable laws, and these documents may not be construed as doing so.

Copyrights

This document is copyrighted by the IEEE. It is made available for a wide variety of both public and private uses. These include both use by reference, in laws and regulations, and use in private self-regulation, standardization, and the promotion of engineering practices and methods. By making this document available for use and adoption by public authorities and private users, the IEEE does not waive any rights in copyright to this document.

Updating of IEEE documents

Users of IEEE standards should be aware that these documents may be superseded at any time by the issuance of new editions or may be amended from time to time through the issuance of amendments, corrigenda, or errata. An official IEEE document at any point in time consists of the current edition of the document together with any amendments, corrigenda, or errata then in effect. In order to determine whether a given document is the current edition and whether it has been amended through the issuance of amendments, corrigenda, or errata, visit the IEEE Standards Association Web site at <http://ieeexplore.ieee.org/xpl/standards.jsp>, or contact the IEEE at the address listed previously.

For more information about the IEEE Standards Association or the IEEE standards development process, visit the IEEE-SA Web site at <http://standards.ieee.org>.

Errata

Errata, if any, for this and all other standards can be accessed at the following URL: <http://standards.ieee.org/reading/ieee/updates/errata/index.html>. Users are encouraged to check this URL for errata periodically.

Interpretations

Current interpretations can be accessed at the following URL: <http://standards.ieee.org/reading/ieee/interp/index.html>.

Patents

Attention is called to the possibility that implementation of this standard may require use of subject matter covered by patent rights. By publication of this standard, no position is taken with respect to the existence or validity of any patent rights in connection therewith. The IEEE is not responsible for identifying Essential Patent Claims for which a license may be required, for conducting inquiries into the legal validity or scope of Patent Claims, or determining whether any licensing terms or conditions provided in connection with submission of a Letter of Assurance, if any, or in any licensing agreements are reasonable or non-discriminatory. Users of this standard are expressly advised that determination of the validity of any patent rights, and the risk of infringement of such rights, is entirely their own responsibility. Further information may be obtained from the IEEE Standards Association.

Participants

At the time this standard was submitted to the IEEE-SA Standards Board for approval, the IEEE C57.13 Revision Working Group had the following membership:

Thomas Nelson, *Chair*

Anthony Jonnatti
Vladimir Khalin
Ross McTaggart

Paul Millward
Pierre Riffon

James E. Smith
Chris TenHaagen
Alejandro Villasenor

The following members of the individual balloting committee voted on this standard. Balloters may have voted for approval, disapproval, or abstention.

Michael Adams
Steven Alexanderson
Javier Arteaga
Ali Al Awazi
Michael Baldwin
G. Bartok
Martin Baur
Robert Beresh
Wallace Binder
Stuart Bouchey
Steven Brockschink
Carl Bush
Keith Chow
Stephen Conrad
Tommy Cooper
Jorge E. Fernandez Daher
Ratan Das
Ronald L. Daubert
Eric J. Davis
F. A. Denbrock
Kevin Donahoe
Randall Dotson
Paul Drum
Donald Dunn
Dureja, Surinder K.
Paul R. Elkin
Gary Engmann
Marcel Fortin
Saurabh Ghosh
Manuel Gonzalez
Charles G. Joseph
Randall Groves
James Gurney
Michael Haas
Jennifer Hanus
Thomas C. Harbaugh
Yusuke Hasegawa
Roger Hedding

Adrienne Hendrickson
Gary Heuston
Jerry Hohn
Donald L. Hornak
John J. Horwath
Dennis Horwitz
James Huddleston
David W. Jackson
David V. James
Jose A. Jarque
James Jones
Gael Kennedy
Joseph L. Koepfinger
Jim Kulchisky
Saumen Kundu
Yeou Song Lee
Blane Leuschner
Lisardo Lopez
William L. Lue
William Lumpkins
William Maguire
Keith N. Malmedal
William J. Marsh
John W. Matthews
Michael McDonald
Mark F. McGranaghan
Michael Meisinger
Joseph Melanson
Gary Michel
Le Quang Minh
William Moncrief
Brian Mugalian
Randolph Mullikin
Jerry Murphy
Kyaw Myint
George Nail
Krzysztof Najdenkoski
Bradley Nelson

Arthur Neubauer
Michael S. Norman
Joe Nims
Gary P. Pender
Thomas P. Pender
Chris Osterloh
Lorraine Padden
Joshua S. Park
Dhiru S. Patel
Ralph Patterson
Allan St. Peter
Vikram Punj
Jeffrey Ray
Johannes Rickmann
Michael Roberts
Thomas Schossig
Robert Schuerger
K. Sebra
Tony Seegers
Donald Sevcik
Devki Sharma
Stephen Shull
Tarlochan Sidhu
Hyeong Sim
Mark Simon
Veselin Skendzic
James E. Smith
Larry E. Smith
Aaron Snyder
Richard Taylor
Eric Udren
Joseph J. Vaschak
D. D. Weers
Ray Young
Roland Youngberg
James Ziebarth
Waldemar Ziomek
Ahmed Zobaa

When the IEEE-SA Standards Board approved this standard on 27 March 2008, it had the following membership:

Robert M. Grow, Chair
Thomas A. Prevost, Vice Chair
Steve M. Mills, Past Chair
Judith Gorman, Secretary

Victor Berman
Richard DeBlasio
Andrew Drozd
Mark Epstein
Alex Gelman
William R. Goldbach
Arnold M. Greenspan

Kenneth S. Hanus
James Hughes
Richard H. Hulett
Young Kyun Kim
Joseph L. Koepfinger*
John Kulick
David J. Law
Glenn Parsons

Ronald C. Petersen
Narayanan Ramachandran
Jon Rosdahl
Anne-Marie Sahazizian
Malcolm V. Thaden
Howard L. Wolfman
Don Wright

*Member Emeritus

Also included are the following nonvoting IEEE-SA Standards Board liaisons:

Satish K. Aggarwal, *NRC Representative*
Michael H. Kelley, *NIST Representative*

Don Messina
IEEE Standards Program Manager, Document Development

Bill Ash
IEEE Standards Program Manager, Technical Program Development

Contents

1. Overview	1
1.1 Scope	1
1.2 Purpose	1
2. Normative references.....	2
3. Definitions.....	2
4. General requirements.....	3
4.1 Service conditions.....	3
4.2 Effect of air density on flashover voltage.....	5
4.3 Frequency	5
4.4 Effect of altitude on temperature rise and effect of ambient temperature on permissible loading.....	5
4.5 Basic impulse insulation levels, dielectric tests, and outdoor instrument transformer creepage distance and wet tests	5
4.6 Temperature rise.....	8
4.7 Tests.....	9
4.8 Construction	10
5. Accuracy classes for metering.....	12
5.1 Basis for accuracy classes.....	12
5.2 Expression of Transformer Correction Factor at 0.6 power factor (lagging) of metered load.....	13
5.3 Standard accuracy classes.....	13
5.4 Limiting values of Ratio Correction Factor and phase angle for standard accuracy classes.....	13
6. Current transformers.....	15
6.1 Terms in which ratings shall be expressed.....	15
6.2 Standard burdens	15
6.3 Accuracy ratings for metering	16
6.4 Accuracy ratings for relaying	18
6.5 Continuous thermal current rating factors based on 30 °C average ambient air temperature.....	19
6.6 Short time current ratings	19
6.7 Secondary winding induced voltages	20
6.8 Nameplate	21
6.9 Terminal.....	21
6.10 Application data.....	21
6.11 Routine accuracy tests	23
7. Voltage transformers	23
7.1 Terms in which ratings shall be expressed	23
7.2 Standard burdens	29
7.3 Accuracy ratings.....	30

7.4 Thermal burden ratings.....	30
7.5 Nameplates	30
7.6 Terminals.....	31
7.7 Short-circuit capability	31
7.8 Application data.....	31
7.9 Induced voltage test.....	31
7.10 Routine accuracy tests	32
8. Test code.....	32
8.1 Ratio and phase angle measurement and calculations	32
8.2 Demagnetization.....	50
8.3 Impedance and excitation measurements.....	52
8.4 Polarity	57
8.5 Resistance measurements	60
8.6 Short-time characteristics	62
8.7 Temperature rise tests	66
8.8 Dielectric tests	70
8.9 Measurement of open-circuit voltage of current transformers.....	74
8.10 Partial discharge measurement	76
Annex A (informative) Bibliography	80

IEEE Standard Requirements for Instrument Transformers

IMPORTANT NOTICE: This standard is not intended to assure safety, security, health, or environmental protection in all circumstances. Implementers of the standard are responsible for determining appropriate safety, security, environmental, and health practices or regulatory requirements.

This IEEE document is made available for use subject to important notices and legal disclaimers. These notices and disclaimers appear in all publications containing this document and may be found under the heading “Important Notice” or “Important Notices and Disclaimers Concerning IEEE Documents.” They can also be obtained on request from IEEE or viewed at <http://standards.ieee.org/IPR/disclaimers.html>.

1. Overview

1.1 Scope

This standard is intended for use as a basis for performance and interchangeability of equipment covered, and to assist in the proper selection of such equipment. Safety precautions are also addressed.

This standard covers certain electrical, dimensional, and mechanical characteristics, and takes into consideration certain safety features of current and inductively coupled voltage transformers of types generally used in the measurement of electricity and the control of equipment associated with the generation, transmission, and distribution of alternating current.

1.2 Purpose

The purpose of this standard is to provide the performance requirements for electrical system and test interchangeability of current and inductively coupled voltage transformers. These transformers are for both indoor and outdoor application.